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Description

The 5P49V6968 is a programmable clock generator that is intended for high-performance consumer, networking, industrial, computing, and data communications applications. This is IDT's sixth generation of programmable clock technology (VersaClock 6E).

The 5P49V6968 generates the frequencies from a single reference clock, which can originate from one of the two redundant clock inputs. A glitchless manual switchover function allows one of the redundant clocks to be selected during normal operation.

Two select pins allow up to four different configurations to be programmed, and can be used for different operating modes.

Typical Applications

- Ethernet switch/router
- PCI Express 1.0/2.0/3.0/4.0
- Broadcast video/audio timing
- Multi-function printer
- Processor and FPGA clocking
- Any-frequency clock conversion
- MSAN/DSLAM/PON
- Fiber Channel, SAN
- Telecom line cards
- Datacenter

Features

- Flexible 1.8V, 2.5V, and 3.3V power rails
- High-performance, low phase noise PLL, < 0.5ps RMS typical phase jitter on outputs
- Four banks of internal OTP memory
 - In-system or factory programmable
- I²C serial programming interface
 - 0xD0 or 0xD4 I²C address options allow multiple devices to be configured in a same system
- Reference LVCMOS output clock
- Three universal configurable outputs (OUT1, 2, 4):
 - Differential (LVPECL, LVDS, or HCSL) 1kHz to 350MHz
 - Two single-ended (in-phase or 180 degrees out of phase) 1kHz to 200MHz
 - I/O VDDs can be mixed and matched, supporting 1.8V (LVDS and LVCMOS), 2.5V, or 3.3V
 - Independent spread spectrum on each output pair
- Eight additional LPHCSL outputs (OUT 3, 5–11)
 - 1.8V low power supply
 - 1kHz to 200MHz
- Programmable output enable or power-down mode
- Redundant clock inputs with manual switchover
- Available in 6 × 6 mm 48-VFQFPN package
- -40° to +85°C industrial temperature operation





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Contents

1.	Pin Assignments							
2.	Pin Descriptions							
3.	Absolute Maximum Ratings							
4.	Thermal Characteristics							
5.	Recommended Operating Conditions							
6.	Electrical Characteristics							
7.	Test Loads							
8.	Jitter Performance Characteristics							
9.	PCI E	Express Ji	ter Performance and Specification	16				
10.	Featu	ires and F	unctional Blocks	17				
	10.1	Device S	tartup and Power-on-Reset	17				
	10.2	Internal	Crystal Oscillator (XIN/REF)	18				
		10.2.1	Choosing Crystals	18				
		10.2.2	Tuning the Crystal Load Capacitor	18				
	10.3	Program	mable Loop Filter	20				
	10.4	Fraction	al Output Dividers (FOD)	20				
		10.4.1	Individual Spread Spectrum Modulation	20				
		10.4.2	Bypass Mode	20				
		10.4.3	Cascaded Mode	20				
		10.4.4	Dividers Alignment	20				
		10.4.5	Programmable Skew	21				
	10.5	Output D	Privers	21				
	10.6	SD/OE F	Pin Function	21				
	10.7	I ² C Oper	ation	22				
11.	Туріс	al Applica	tion Circuit	23				
	11.1	Input – E	Driving the XIN/REF	24				
		11.1.1	Driving XIN/REF with a CMOS Driver	24				
		11.1.2	Driving XIN with a LVPECL Driver	25				
	11.2	Output –	Single-ended or Differential Clock Terminations	26				
		11.2.1	LVDS Termination	26				
		11.2.2	LVPECL Termination	27				
		11.2.3	HCSL Termination	28				
		11.2.4	LVCMOS Termination	28				
12.	Packa	age Outlin	e Drawings	29				
13.	Marki	ng Diagra	m	29				
14.	Order	ringInform	ation	29				
15.	Revis	ion Histor	Revision History					

1. Pin Assignments



Figure 1. Pin Assignments for 6×6 mm 48-VFQFPN Package – Top View

2. Pin Descriptions

Table 1. Pin Descriptions

Pin	Name	Туре		Description
1	OUT10B	Output		Complementary output clock 10. Low-power HCSL (LP-HCSL) output.
2	XOUT	Output		Crystal oscillator interface output.
3	XIN/REF	Input		Crystal oscillator interface input, or single-ended LVCMOS clock input. Input voltage is 1.2V max.
4	VDDA	Power		Analog functions power supply pin. Connect to 1.8V.
5	VDDO	Power		Connect to 1.8V. Power pin for outputs 3, and 5–11

Pin	Name	Ту	/pe	Description
6	OUT9	Output		Output clock 9. Low-power HCSL (LP-HCSL) output.
7	OUT9B	Output		Complementary output clock 9. Low-power HCSL (LP-HCSL) output.
8	OUT8	Output		Output clock 8. Low-power HCSL (LP-HCSL) output.
9	OUT8B	Output		Complementary output clock 8. Low-power HCSL (LP-HCSL) output.
10	OUT7	Output		Output clock 7. Low-power HCSL (LP-HCSL) output.
11	OUT7B	Output		Complementary output clock 7. Low-power HCSL (LP-HCSL) output.
12	SD/OE	Input	Internal Pull- down	Enables/disables the outputs (OE) or powers down the chip (SD). The SH bit controls the configuration of the SD/OE pin. The SH bit needs to be high for SD/OE pin to be configured as SD. The SP bit (0x02) controls the polarity of the signal to be either active HIGH or LOW only when the pin is configured as OE (Default is active LOW.) It has a weak internal pull-down resistor. When configured as SD, the device is shut down, differential outputs are driven high/low, and the single-ended LVCMOS outputs are driven low. When configured as OE, and outputs are disabled, the outputs can be selected to be tri-stated or driven high/low depending on the programming bits as discussed in "SD/OE Pin Function".
13	SEL1/SDA	Input	Internal Pull-down	Configuration select pin, or I ² C SDA input as selected by OUT0_SEL_I2CB. It has a weak internal pull-down resistor.
14	SEL0/SCL	Input	Internal Pull-down	Configuration select pin, or I ² C SCL input as selected by OUT0_SEL_I2CB. It has a weak internal pull-down resistor.
15	VDD	Power		Connect to 1.8V.
16	VDDO	Power		Connect to 1.8V. Power pin for outputs 3, and 5–11.
17	OUT6	Output		Output clock 6. Low-power HCSL (LP-HCSL) output.
18	OUT6B	Output		Complementary output clock 6. Low-power HCSL (LP-HCSL) output.
19	OUT5	Output		Output clock 5. Low-power HCSL (LP-HCSL) output.
20	OUT5B	Output		Complementary output clock 5. Low-power HCSL (LP-HCSL) output.
21	VDDO4	Power		Connect to 1.8V to 3.3V. VDD supply for OUT4.
22	OUT4	Output		Output clock 4. For more information, see "Output Drivers."
23	OUT4B	Output		Complementary output clock 4. For more information, see "Output Drivers."
24	OEA	Input	Internal Pull-down	Active low output enable pin for outputs 3, 5, 6, and 11. 0 = Enable outputs, 1 = Disable outputs. This pin has an internal pull-down.
25	NC	_		Do not connect.
26	NC			Do not connect.
27	VDDO	Power		Connect to 1.8V. This is a power pin for outputs 3, and 5–11.
28	OUT3B	Output		Complementary output clock 3. Low-power HCSL (LP-HCSL) output.
29	OUT3	Output		Output clock 3. Low-power HCSL (LP-HCSL) output.
30	VDD_Core	Power		Connect to 1.8V.
31	VDD	Power		Connect to 1.8V.

Pin	Name	Ту	/pe	Description
32	NC	Input		Do not connect.
33	OEB7_10	Input	Internal Pull-down	Active low output enable pin for outputs 7–10. 0 = Enable outputs; 1 = Disable outputs. This pin has an internal pull-down.
34	OUT2B	Output		Complementary output clock 2. For more information, see "Output Drivers."
35	OUT2	Output		Output clock 2. For more information, see "Output Drivers."
36	VDDO2	Power		Connect to 1.8V to 3.3V. VDD supply for OUT2
37	OUT1B	Output		Complementary output clock 1. For more information, see "Output Drivers."
38	OUT1	Output		Output clock 1. For more information, see "Output Drivers."
39	VDDO1	Power		Connect to 1.8V to 3.3V. VDD supply for OUT1.
40	NC	-		Do not connect.
41	OUT11	Output		Output clock 11. Low-power HCSL (LP-HCSL) output.
42	OUT11B	Output		Complementary output clock 11. Low-power HCSL (LP-HCSL) output.
43	VDDO	Power		Connect to 1.8V. Power pin for outputs 3, and 5–11
44	VDD	Power		Connect to 1.8V.
45	OE_buffer	Input	Internal Pull- up	Active High Output enable for outputs 3, and 5–11. 0 = Disable outputs; 1 = Enable outputs. This pin has an internal pull-up.
46	VDDO0	Power		Power supply pin for OUT0_SEL_I2CB and crystal oscillation. Connect to 1.8 to 3.3V. It sets the output voltage levels for OUT0.
47	OUT0_SEL_ I2CB	Output	Internal Pull- down	Latched input/LVCMOS Output. At power up, the voltage at the pin OUT0_SEL_I2CB is latched by the part and used to select the state of pins 13 and 14. If a weak pull-up (10Kohms) is placed on OUT0_SEL_I2CB, pins 13 and 14 will be configured as hardware select pins, SEL1 and SEL0. If a weak pull-down (10Kohms) is placed on OUT0_SEL_I2CB or it is left floating, pins 13 and 14 will act as the SDA and SCL pins of an I ² C interface. After power up, the pin acts as a LVCMOS reference output.
48	OUT10	Output		Output clock 10. Low-power HCSL (LP-HCSL) output.
ePAD	GND	GND		Connect to ground pad

3. Absolute Maximum Ratings

The absolute maximum ratings are stress ratings only. Stresses greater than those listed below can cause permanent damage to the device. Functional operation of the device at absolute maximum ratings is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Table 2. Absolute Maximum Ratings

Item	Rating
Supply Voltage, V _{DDA} , V _{DDD} , V _{DDO}	3.465V
XIN/REF Input	1.2V
I ² C Loading Current (SDA)	10mA
Storage Temperature, TSTG	-65°C to 150°C
ESD Human Body Model	2000V

4. Thermal Characteristics

Table 3. Thermal Characteristics

Symbol	Parameter	Value	Units
θ_{JA}	Theta JA. Junction to air thermal impedance (0mps)	41.05	°C/W
θ_{JB}	Theta JB. Junction to board thermal impedance (0mps)	13.6	°C/W
θJC	Theta JC. Junction to case thermal impedance (0mps)	36.41	°C/W

5. Recommended Operating Conditions

Table 4. Recommended Operating Conditions

Symbol	Parameter	Minimum	Typical	Maximum	Units
	Power supply voltage for supporting 1.8V outputs.	1.71	1.8	1.89	V
V _{DDOX}	Power supply voltage for supporting 2.5V outputs.	2.375	2.5	2.625	V
	Power supply voltage for supporting 3.3V outputs.	3.135	3.3	3.465	V
V _{DDD}	Power supply voltage for core logic functions.	1.71		3.465	V
V _{DDA}	Analog power supply voltage. Use filtered analog power supply.	1.71		3.465	V
T _A	Operating temperature, ambient.	-40		85	°C
CL	Maximum load capacitance (3.3V LVCMOS only).			15	pF

6. Electrical Characteristics

Table 5. Current Consumption Characteristics

 V_{DDA} , V_{DDD} , $V_{DD00} = 3.3V \pm 5\%$, $2.5V \pm 5\%$, $1.8V \pm 5\%$, $T_A = -40^{\circ}C$ to $+85^{\circ}C$.

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
I _{DDCORE} [a]	Core Supply Current	100MHz on all outputs		30		mA
	Output Buffer Supply	LVPECL, 350MHz, 3.3V V _{DDOx}		42		mA
	Current	LVPECL, 350MHz, 2.5V V _{DDOx}		37		mA
		LVDS, 350MHz, 3.3V V _{DDOx}		18		mA
		LVDS, 350MHz, 2.5V V _{DDOx}		17		mA
		LVDS, 350MHz, 1.8V V _{DDOx}		16		mA
		HCSL, 250MHz, 3.3V V _{DDOx} ^[b]		29		mA
I _{DDOX}		HCSL, 250MHz, 2.5V V _{DDOx} ^[b]		28		mA
		LVCMOS, 50MHz, 3.3V, V _{DDOx} ^{[b],[c]}		16		mA
		LVCMOS, 50MHz, 2.5V, V _{DDOx} ^{[b],[c]}		14		mA
		LVCMOS, 50MHz, 1.8V, V _{DDOx} ^{[b],[c]}		12		mA
		LVCMOS, 200MHz, 3.3V V _{DDOx} [b],[c]		36		mA
		LVCMOS, 200MHz, 2.5V V _{DDOx} [b],[c]		27		mA
		LVCMOS, 200MHz, 1.8V V _{DDOx} ^{[b],[c]}		16		mA
IDDPD	Power Down Current	SD asserted, I ² C programming.		10		mA

[a] $I_{DDCORE} = I_{DDA} + I_{DDD}$, no loads.

[b] Measured into a 5" 50Ω trace with a 2pF load.

[c] Single CMOS driver active.

Table 6. AC Timing Characteristics

V _{DDA} , V _{DDD} , V _{DDO0}	= 3.3V ±5%, 2.5\	/ ±5%, 1.8V ±5%	T _A = -40°C to	+85°C, I	unless stated o	otherwise.
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Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
F _{IN} ^[a]	Input Frequency	Input frequency limit (Crystal)	8		40	MHz
		Input frequency limit (Single-ended over XIN)	1		200	
		Single-ended clock output limit (LVCMOS), individual FOD mode.	1		200	
		Differential clock output (LVPECL/LVDS/HCSL), individual FOD mode.	0.001		350	
F _{OUT} ^[b]	Output Frequency	Single-ended clock output limit (LVCMOS), cascaded FOD mode, output 2, 4.	0.001		200	MHz
		Differential clock output limit (LVPECL/LVDS/HCSL), cascaded FOD mode, output 2, 4.	0.001		350	
		Differential clock output (LP-HCSL output 3, 5–11)	0.001		200	
fVCO	VCO Operating Frequency Range		2500		2900	MHz
	Output Duty Cycle	Measured at $V_{DD}/2$, all outputs except reference output, $V_{DDOX} = 2.5V$ or 3.3V.	45	50	55	%
		Measured at $V_{DD}/2$, all outputs except reference output, $V_{DDOX} = 1.8V$	40	50	60	%
T _{DC} [c]		Measured at V _{DD} /2, reference output OUT0 (5–150.1MHz) with 50% duty cycle input.	40	50	60	%
		Measured at V _{DD} /2, reference output OUT0 (150.1–200MHz) with 50% duty cycle input.	30	50	70	%
T _{SKEW}	Output Skew	Skew between the same frequencies, with outputs using the same driver format and phase delay set to 0ns.		75		ps
T _{STARTUP} ^{[d] [e]}	Startup Time	Measured after all $V_{\text{DD}}\text{s}$ have raised above 90% of their target value. $^{[f]}$			30	ms
- orninor		PLL lock time from shutdown mode.		3	4	ms

[a] Practical lower frequency is determined by loop filter settings.

[b] A slew rate of 2.75V/ns or greater should be selected for output frequencies of 100MHz or higher.

[c] Duty cycle is only guaranteed at maximum slew rate settings.

[d] Actual PLL lock time depends on the loop configuration.

[e] Includes loading the configuration bits from EPROM to PLL registers. It does not include EPROM programming/write time.

[f] Power-up with temperature calibration enabled, please contact IDT if shorter lock-time is required in system.

Table 7. Input Characteristics

V_DDA, V_DDD, V_DDO0 = $3.3V \pm 5\%$, $2.5V \pm 5\%$, $1.8V \pm 5\%$, $T_A = -40^{\circ}C$ to $+85^{\circ}C$, unless stated otherwise.

Symbol	Parameter	Pins	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance	SD/OE,SEL1/SDA, SEL0/SCL		3	7	pF
R _{PD}	Pull-down Resistor	SD/OE, SEL1/SDA, SEL0/SCL, OUT0_SEL_I2CB	100		300	kΩ
VIH	Input High Voltage	SD/OE	0.7 x V _{DDD}		V _{DDD} + 0.3	V
VIL	Input Low Voltage	SD/OE	GND - 0.3		0.3 x V _{DDD}	V
V _{IH}	Input High Voltage	OUT0_SEL_I2CB	0.65 x V _{DDO0}		V _{DDO0} + 0.3	V
VIL	Input Low Voltage	OUT0_SEL_I2CB	GND - 0.3		0.4	V
V _{IH}	Input High Voltage	XIN/REF	0.8		1.2	V
V _{IL}	Input Low Voltage	XIN/REF	GND - 0.3		0.4	V
T _R /T _F	Input Rise/Fall Time	SD/OE, SEL1/SDA, SEL0/SCL			300	ns

Table 8. Electrical Characteristics – CMOS Outputs

 V_{DDA} , V_{DDD} , $V_{DDO0} = 3.3V \pm 5\%$, 2.5V $\pm 5\%$, 1.8V $\pm 5\%$, T_A = -40°C to +85°C, unless stated otherwise.

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage	IOH = -15mA (3.3V), -12mA (2.5V), -8mA (1.8V)	0.7 x V _{DDO}		V _{DDO}	V
V _{OL}	Output Low Voltage	IOH = 15mA (3.3V), 12mA (2.5V), 8mA (1.8V)			0.4	۷
R _{OUT}	Output Driver Impedance	CMOS Output Driver		17		Ω
	Slew Rate, SLEW[1:0] = 00		1.0	2.2		
	Slew Rate, SLEW[1:0] = 01	Single-ended 3.3V LVCMOS output clock rise and	1.2	2.3		
	Slew Rate, SLEW[1:0] = 10	fail time, 20% to 80% of VDDO (output load = 5pF) $-$ V _{DDOX} = 3.3V	1.3	2.4		- V/ns
	Slew Rate, SLEW[1:0] = 11		1.7	2.7		
	Slew Rate, SLEW[1:0] = 00	Single-ended 2.5V LVCMOS output clock rise and fall time 20% to 80% of VDDO (output load - 5PE)	0.6	1.3		
Т	Slew Rate, SLEW[1:0] = 01		0.7	1.4		
I SR	Slew Rate, SLEW[1:0] = 10	$V_{\text{DDOX}} = 2.5V$	0.6	1.4		
	Slew Rate, SLEW[1:0] = 11		1.0	1.7		
	Slew Rate, SLEW[1:0] = 00		0.3	0.7		
	Slew Rate, SLEW[1:0] = 01	Single-ended 1.8V LVCMOS output clock rise and	0.4	0.8		
	Slew Rate, SLEW[1:0] = 10	VDD = 1.8V.	0.4	0.9		
	Slew Rate, SLEW[1:0] = 11		0.7	1.2		
	Output Leakage Current (OUT1-4)	Tri-state outputs			5	μA
IOZDD	Output Leakage Current (OUT0)	Tri-state outputs			30	μA

Table 9. Electrical Characteristics – LVDS Outputs

 V_{DDA} , V_{DDD} , $V_{DDO0} = 3.3V \pm 5\%$, 2.5V $\pm 5\%$, 1.8V $\pm 5\%$, T_A = -40°C to +85°C, unless stated otherwise.

Symbol	Parameter		Typical	Maximum	Units
V _{OT} (+)	Differential Output Voltage for the TRUE Binary State	247		454	mV
V _{OT} (-)	Differential Output Voltage for the FALSE Binary State	-454		-247	mV
ΔV_{OT}	Change in V _{OT} between Complimentary Output States			50	mV
V	Output Common Mode Voltage (Offset Voltage) at 3.3V±5%, 2.5V±5%	1.125	1.25	1.375	V
VOS	Output Common Mode Voltage (Offset Voltage) at 1.8V±5%	0.8	0.875	0.96	V
ΔV_{OS}	Change in V _{OS} between Complimentary Output States			50	mV
I _{OS}	Outputs Short Circuit Current, V_{OUT} + or V_{OUT} - = 0V or V_{DDO}		9	24	mA
I _{OSD}	SD Differential Outputs Short Circuit Current, V _{OUT} + = V _{OUT} -		6	12	mA
T _R	LVDS rise time 20%-80%		300		ps
T _F	LVDS fall time 80%-20%		300		ps

Table 10. Electrical Characteristics – LVPECL Outputs

 $V_{\text{DDA}},\,V_{\text{DDD}},\,V_{\text{DDO0}}$ = 3.3V ±5%, 2.5V ±5%, T_{A} = -40°C to +85°C, unless stated otherwise.

Symbol	Parameter		Typical	Maximum	Units
V _{OH}	Output Voltage High, terminated through 50 Ω tied to V_DD - 2V	V _{DDO} - 1.19		V _{DDO} - 0.69	V
V _{OL}	Output Voltage Low, terminated through 50 Ω tied to V_DD - 2V			V _{DDO} - 1.4	V
V _{SWING}	Peak-to-Peak Output Voltage Swing	0.55		0.993	V
T _R	LVPECL rise time 20%-80%		400		ns
T _F	LVPECL fall time 80%-20%		400		ns

Table 11. Electrical Characteristics – HCSL Outputs^[a]

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
dV/dt	Slew Rate	Scope averaging on [b] [c]	1		4	V/ns
∆dV/dt	Slew Rate Matching	Scope averaging on [b] [c]			20	%
V _{MAX}	Maximum Voltage	Measurement on single-ended signal using			1150	mV
V _{MIN}	Minimum Voltage	absolute value (scope averaging off)	-300			mV
V _{SWING}	Voltage Swing	Scope averaging off [b] [f]	300			mV
V _{CROSS}	Crossing Voltage Value	Scope averaging off [d] [f]	250		550	mV
ΔV_{CROSS}	Crossing Voltage Variation	Scope averaging off [e]			140	mV

 $V_{\text{DDA}},\,V_{\text{DDD}},\,V_{\text{DDO0}}$ = 3.3V ±5%, 2.5V ±5%, T_{A} = -40°C to +85°C, unless stated otherwise.

[a] Guaranteed by design and characterization. Not 100% tested in production.

[b] Measured from differential waveform.

[c] Slew rate is measured through the VSWING voltage range centered on differential 0V. This results in a ±150mV window around differential 0V.

[d] VCROSS is defined as voltage where Clock = Clock# measured on a component test board and only applies to the differential rising edge (i.e., Clock rising and Clock# falling).

[e] The total variation of all VCROSS measurements in any particular system. Note that this is a subset of VCROSS min/max (VCROSS absolute) allowed. The intent is to limit VCROSS induced modulation by setting ΔVCROSS to be smaller than VCROSS absolute.

[f] Measured from single-ended waveform.

Table 12. Spread-Spectrum Generation Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
fssouт	Spread Frequency	Output frequency range for spread spectrum 5			300	MHz
f _{MOD}	Mod Frequency	Modulation frequency.	30 to 63			kHz
	Spread Value	Amount of spread value (programmable)-center spread.	±0.25% to ±2.5%		.5%	0/af
ISPREAD Spread Value		Amount of spread value (programmable)-down spread.	-0.5% to -5%		/ײOUT	

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
V _{IH}	Input High Level	For SEL1/SDA pin and SEL0/SCL pin.	0.7 x V _{DDD}			V
V _{IL}	Input Low Level	For SEL1/SDA pin and SEL0/SCL pin.			0.3 x V _{DDD}	V
V _{HYS}	Hysteresis of Inputs		$0.05 \times V_{DDD}$			V
I _{IN}	Input Leakage Current		-1		30	μÂ
V _{OL}	Output Low Voltage	I _{OL} = 3mA			0.4	V

Table 13. I²C Bus (SCL/SDA) DC Characteristics

Table 14. I²C Bus (SCL/SDA) AC Characteristics

Symbol	Parameter	Minimum	Typical	Maximum	Units
F _{SCLK}	Serial Clock Frequency (SCL)	10		400	kHz
t _{BUF}	Bus Free Time between Stop and Start	1.3			μs
t _{SU:START}	Setup Time, Start	0.6			μs
t _{HD:START}	Hold Time, Start	0.6			μs
t _{SU:DATA}	Setup Time, Data Input (SDA)	0.1			μs
t _{HD:DATA}	Hold Time, Data Input (SDA) ¹	0			μs
t _{OVD}	Output Data Valid from Clock			0.9	μs
CB	Capacitive Load for Each Bus Line			400	рF
t _R	Rise Time, Data and Clock (SDA, SCL)	20 + 0.1 x C _B		300	ns
t _F	Fall Time, Data and Clock (SDA, SCL)	20 + 0.1 x C _B		300	ns
t _{HIGH}	High Time, Clock (SCL)	0.6			μs
t _{LOW}	Low Time, Clock (SCL)	1.3			μs
t _{SU:STOP}	Setup Time, Stop	0.6			μs

[a] A device must internally provide a hold time of at least 300ns for the SDA signal (referred to the V_{IH(MIN)} of the SCL signal) to bridge the undefined region of the falling edge of SCL.

[b] I²C inputs are 5V tolerant.

7. Test Loads

Figure 2. LVCMOS Test Load



Figure 3. HCSL/LPHCSL Test Load











8. Jitter Performance Characteristics





Note: Measured with OUT2=156.25MHz on, 39.625MHz input.

Table 15. Jitter Performance^{[a] [b]}

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Units
J _{CY-CY}	Cycle to Cycle Jitter	LVCMOS 3.3V ±5%,-40°C to 90°C		5	30	ps
		All differential outputs 3.3V \pm 5%,-40°C to 90°C		25	35	ps
J _{pk-pk}	Period Jitter	LVCMOS 3.3V ±5%,-40°C–90°C		28	40	ps
		All differential outputs 3.3V \pm 5%,-40°C to 90°C		4	30	ps
J _{RMS}	RMS Phase Jitter	LVCMOS 3.3V ±5%,-40°C to 90°C		0.3		ps
	(12kHz-20MHz)	All differential outputs 3.3V \pm 5%,-40°C to 90°C		0.5		ps

[a] Measured with 25MHz crystal input.

[b] Configured with OUT0 = 25MHz–LVCMOS OUT1 = 100MHz HCSL OUT2 = 125MHz LVDS OUT3 = 156.25MHz–LVPECL.

9. PCI Express Jitter Performance and Specification

Table 16. PCI Express Jitter Performance [a] [b]

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Industry Limit	Units
	tjphPCleG1-CC	PCIe Gen 1 ^[c]		28.7		86	ps (p-p)
tjphPCleG2-CC		PCIe Gen 2 Low Band 10kHz < f < 1.5MHz (PLL BW of 5-16MHz, 8-16MHz, CDR = 5MHz)		0.27		3	ps (rms)
PCIe Jitter (Common Clock-CC)		PCIe Gen 2 High Band 1.5MHz < f < Nyquist (50MHz) (PLL BW of 5-16MHz, 8-16MHz, CDR = 5MHz)		2.56		3.1	ps (rms)
	tjphPCleG3-CC	PCIe Gen 3 (PLL BW of 2-4MHz, 2-5MHz, CDR = 10MHz)		0.8		1	ps (rms)
	tjphPCleG4-CC	PCIe Gen 4 (SSC OFF) (PLL BW of 2-4MHz, 2-5MHz, CDR = 10MHz)		0.26		0.5	ps (rms)
PCle Jitter	t _{jphPCleG2} - SRNS	PCIe Gen 2 (SSC OFF) (PLL BW of 16MHz , CDR = 5MHz)		0.93		2	ps (rms)
(IR) ^{[d][e]}	t _{jphPCleG3} - SRNS	PCIe Gen 3(SSC OFF) (PLL BW of 2-4MHz or 2-5MHz, CDR = 10MHz)		0.32		0.7	ps (rms)

[a] Guaranteed by design and characterization, not 100% tested in production.

[b] Based on PCIe Base Specification Rev4.0 version 1.0. For the latest specifications, see www.pcisig.com.

[c] Sample size of at least 100K cycles. This figure extrapolates to 108ps pk-pk at 1M cycles for a BER of 1-12.

[d] According to the PCIe Base Specification Rev4.0 version 1.0, the jitter transfer functions and corresponding jitter limits are not defined for the IR clock architecture. Widely accepted industry limits using widely accepted industry filters are used to populate this table. There are no accepted filters or limits for IR clock architectures at PCIe Gen1 or Gen4 data rates.

[e] IR (Independent Reference) is the new name for Separate Reference Independent Spread (SRIS) and Separate Reference no Spread (SRNS) PCIe clock architectures.

10. Features and Functional Blocks

10.1 Device Startup and Power-on-Reset

The 5P49V6968 has an internal power-up reset (POR) circuit. All VDDs must be connected to the desired supply voltage to trigger a POR.

The user can define specific default configurations through internal One-Time-Programmable (OTP) memory -- either the user or factory can program the default configuration. Contact IDT if a specific factory-programmed default configuration is required, or refer to the *VersaClock 6E Programming Guide*.

The device will identity which of the two modes to operate in by the state of the OUT0_SEL_I2CB pin at POR. Both modes' default configurations can be programmed as follows:

1. Software Mode (I²C): OUT0_SEL_I2CB is low at POR.

The I²C interface will be open to users for in-system programming, overriding device default configurations at any time.

2. Hardware Select Mode: OUT0_SEL_I2CB is high at POR.

The device has been programmed to load OTP at power-up (REG0[7] = 1). The device will load internal registers according to Table 17. Internal OTP memory can support up to four configurations, which selectable by the SEL0/SEL1 pins.

At POR, logic levels at SEL0 and SEL1 pins must be settled, which results in the selected configuration to be loaded at power up.

After the first 10ms of operation, the levels of the SELx pins can be changed, either to low or to the same level as VDDD/VDDA. The SELx pins must be driven with a digital signal of < 300ns rise/fall time and only a single pin can be changed at a time. After a pin level change, the device must not be interrupted for at least 1ms so that the new values have time to load and take effect.

OUT0_SEL_I2CB at POR	SEL1	SEL0	l ² C Access	REG0:7	Config
1	0	0	No	0	0
1	0	1	No	0	1
1	1	0	No	0	2
1	1	1	No	0	3
0	Х	Х	Yes	1	I ² C defaults
0	Х	Х	Yes	0	0

Table 17. Power-Up Behavior

10.2 Internal Crystal Oscillator (XIN/REF)

10.2.1 Choosing Crystals

A crystal manufacturer will calibrate its crystals to the nominal frequency with a certain load capacitance value. When the oscillator load capacitance matches the crystal load capacitance, the oscillation frequency will be accurate. When the oscillator load capacitance is lower than the crystal load capacitance, the oscillation frequency will be higher than nominal and vice versa. Therefore, for an accurate oscillation frequency you must match the oscillator load capacitance with the crystal load capacitance.

10.2.2 Tuning the Crystal Load Capacitor

Cs1 and Cs2 are stray capacitances at each crystal pin and typical values are between 1pF and 3pF (see Figure 7).

Ce1 and Ce2 are additional external capacitors. Increasing the load capacitance reduces the oscillator gain, so it is recommended to consult the manufacturer when adding Ce1 and/or Ce2 to avoid crystal startup issues.

Ci1 and Ci2 are integrated programmable load capacitors, one at XIN and one at XOUT.

Figure 7. Tuning the Crystal Load Capacitor



The value of each capacitor is composed of a fixed capacitance amount plus a variable capacitance amount set with the XTAL[5:0] register. Ci1 and Ci2 are commonly programmed to be the same value. Adjustment of the crystal tuning capacitors allows maximum flexibility to accommodate crystals from various manufacturers. The range of tuning capacitor values available are in accordance with the following table. Ci1/Ci2 starts at 9pF with the setting 000000b, and can be increased up to 25pF with the setting 111111b. The step per bit is 0.5pF.

 Table 18.
 XTAL[5:0] Tuning Capacitor

Parameter	Bits	Step (pF)	Min (pF)	Max (pF)
XTAL	6	0.5	9	25

You can write the following equation for this capacitance:

 $Ci = 9pF + 0.5pF \times XTAL[5:0]$

 $C_{XIN} = Ci1 + Cs1 + Ce1$

 $C_{XOUT} = Ci2 + Cs2 + Ce2$

The final load capacitance of the crystal:

 $C_L = C_{XIN} \times C_{XOUT} / (C_{XIN} + C_{XOUT})$

It is recommended to set the same value at each crystal pin meaning:

 $C_{XIN} = C_{XOUT}$

Example 1: The crystal load capacitance is specified as 8pF and the stray capacitance at each crystal pin is Cs = 1.5pF. Assuming an equal capacitance value at XIN and XOUT, the equation is as follows:

 $\begin{array}{l} 8pF = (9pF + 0.5pF \times XTAL[5:0] + 1.5pF) \, / \, 2 \\ So, \, XTAL[5:0] = 11 \; (decimal) \end{array}$

Example 2: The crystal load capacitance is specified as 12pF and the stray capacitance Cs is unknown. Footprints for external capacitors Ce are added and a worst case Cs of 5pF is used. This example uses Cs + Ce = 5pF; the correct value for Ce can be determined later to make 5pF together with Cs.

12pF = (9pF + 0.5pF \times XTAL[5:0] + 5pF) / 2 So, XTAL[5:0] = 20 (decimal)

Table 19. Recommended Crystal Characteristics

Parameter	Minimum	Typical	Maximum	Units
Mode of Oscillation		Fundamental		
Frequency	8	25	40	MHz
Equivalent Series Resistance (ESR)		10	100	Ω
Shunt Capacitance			7	pF
Load Capacitance (C_L) at < = 25MHz	6	8	12	pF
Load Capacitance (C_L) > 25MHz to 40MHz	6		8	pF
Maximum Crystal Drive Level			100	μŴ

10.3 Programmable Loop Filter

The device PLL loop bandwidth operating range depends on the input reference frequency (Fref).

Input Reference Frequency (MHz)	Loop Bandwidth Minimum (kHz)	Loop Bandwidth Maximum (kHz)
1	40	126
350	300	1000

 Table 20.
 Loop Filter Settings

10.4 Fractional Output Dividers (FOD)

The 5P49V6968 has four fractional output dividers (FOD). Each FOD is comprised of a 12-bit integer counter and a 24-bit fractional counter. The output divider can operate in integer divide only mode for improved performance, or use the fractional counters to generate a clock frequency accurate to 50ppb.

FODs support the following features.

10.4.1 Individual Spread Spectrum Modulation

The output clock frequencies can be modulated to spread energy across a broader range of frequencies, thereby lowering system EMI. Each divider has individual spread ability. Spread modulation independent of output frequency, a triangle wave modulation between 30 and 63kHz.

Spread spectrum can be applied to any output clock, clock frequency, or spread amount from $\pm 0.25\%$ to $\pm 2.5\%$ center-spread and -0.5% to -5% down-spread.

10.4.2 Bypass Mode

Bypass mode (divide by 1) allows the output to behave as a buffered copy from the input or another FOD.

10.4.3 Cascaded Mode

As shown in the block diagram on page 1, FODs can be cascaded for lower output frequency.

For example, if OUT1 is configured to run at 12.288MHz and needs another 48kHz output, the user can cascade FOD2 by taking input from OUT1, with a divide ratio of 256. As a result, OUT 2 runs at 48kHz while in alignment with 12.288MHz on OUT1.

10.4.4 Dividers Alignment

Each output divider block has a synchronizing pulse to provide startup alignment between outputs dividers. This allows alignment of outputs for low skew performance.

When the 5P49V6968 is in hardware select mode, outputs are automatically aligned at POR. The same synchronization reset is also triggered when switching between configurations with the SEL0/1 pins. This ensures that the outputs remain aligned in every configuration.

When the 5P49V6968 is using software mode, I²C is used to reprogram an output divider during operation, and therefore, alignment can be lost. Alignment can be restored by manually triggering a reset through I²C.

The outputs are aligned on the falling edges of each output by default. Rising edge alignment can also be achieved by using the programmable skew feature to delay the faster clock by 180 degrees. The programmable skew feature also allows for fine tuning of the alignment.

10.4.5 Programmable Skew

The 5P49V6968 can skew outputs by quadrature values. The skew on each output can be adjusted from 0 to 360 degrees. Skew is adjusted in units equal to 1/32 of the VCO period. As a result, for 100MHz output and a 2800MHz VCO, the user can select how many 11.161ps units to be added to the skew (resulting in units of 0.402 degrees). For example, 0, 0.402, 0.804, 1.206, 1.408, and so on. The granularity of the skew adjustment is always dependent on the VCO period and the output period.

10.5 Output Drivers

Device output drivers can individually support the following features:

- 2.5V or 3.3V voltage level for HCSL/LVPECL operation
- 1.8V, 2.5V, or 3.3V voltage levels for CMOS/LVDS operation
- CMOS supports four operating modes:
 - CMOSD: OUTx and OUTxB 180 degrees out of phase
 - CMOSX2: OUTx and OUTxB phase-aligned
 - CMOS1: only OUTx pin is on
 - CMOS2: only OUTxB pin is on

When a given output is configured to CMOSD or CMOSX2, then all previously described configuration and control apply equally to both pins.

- Independent output enable/disabled by register bits. When disabled, an output can be either in a logic 1 state or Hi-Z.

The following options are used to disable outputs:

- Output turned off by I²C
- Output turned off by SD/OE pin
- Output unused, which means it is turned off regardless of OE pin status

10.6 SD/OE Pin Function

The SD/OE pin can be programmed as follows:

- OE output enable (low active)
- OE output enable (high active)
- Global shutdown (low active)
- Global shutdown (high active)

Output behavior when disabled is also programmable. The user can select the output driver behavior when it is off as follows:

- OUTx pin high, OUTxB pin low (controlled by SD/OE pin)
- OUTx/OUTxB Hi-Z (controlled by SD/OE pin)
- OUTx pin high, OUTxB pin low (configured through I²C)
- OUTx/OUTxB Hi-Z (configured by I²C)

The user can disable the output with either I²C or SD/OE pin. For more information, see the VersaClock 6E Programming Guide.

10.7 I²C Operation

The 5P49V6968 acts as a slave device on the I²C bus using one of the two I²C addresses (0xD0 or 0xD4) to allow multiple devices to be used in the system. The interface accepts byte-oriented block write and block read operations.

Address bytes (2 bytes) specify the register address of the byte position of the first register to write or read.

Data bytes (registers) are accessed in sequential order from the lowest to the highest byte (most significant bit first).

Read and write block transfers can be stopped after any complete byte transfer. During a write operation, data will not be moved into the registers until the STOP bit is received, at which point, all data received in the block write will be written simultaneously.

For full electrical I²C compliance, use external pull-up resistors for SDATA and SCLK.

Figure 8. I²C R/W Sequence

Curr	ent Read																	
s	Dev Addr + R	A	Data 0	A	Data 1	А	000	A	Data r	h Abar	P							
Sequ	uential Read																	
s	Dev Addr + W	A	Reg start Add	A	Sr	Dev A	ddr + R	A	Data 0	A	Da	ta 1	A 0	000	A	Data n	Abar	Р
Sequ	ential Write								_						_			
s	Dev Addr + W	А	Reg start Add	A	Da	ta O	A	Data 1	А	000	А	Data n	A	8	>			
from master to slave from slave to master			S = s Sr = A = s Aba	start repeate acknow r= none	ed start ledge acknow	ledge							-11					

11. Typical Application Circuit

Figure 9. Typical Application Circuit



11.1 Input – Driving the XIN/REF

11.1.1 Driving XIN/REF with a CMOS Driver

In some instances, it is preferable to have XIN/REF driven by a clock input -- for reasons such as better SNR, multiple input select with device CLKIN, etc. The XIN/REF pin can take an input when its amplitude is between 500mV and 1.2V, and the slew rate less than 0.2V/ns. The XIN/REF input can be overdriven by an LVCMOS driver or by one side of a differential driver through an AC coupling capacitor. The XOUT pin can be left floating.





Table 21. Nominal Voltage Divider Values for Overdriving CLKIN with Single-ended Driver

LVCMOS Diver V _{DD}	Ro + Rs	R1	R2	V_XIN (peak)	Ro+Rs+R1+R2
3.3	50.0	130	75	0.97	255
2.5	50.0	100	100	1.00	250
1.8	50.0	62	130	0.97	242

11.1.2 Driving XIN with a LVPECL Driver

Figure 11 shows an example of the interface diagram for a 3.3V LVPECL driver. This is a standard LVPECL termination with one side of the driver feeding the XIN/REF input. It is recommended that all components in the schematic be placed in the layout; though some components may not be used, they can be used for debugging purposes. The datasheet specifications are characterized and guaranteed using a quartz crystal as the input. If the driver is 2.5V LVPECL, the only required change is to use the appropriate R3 value.





Table 22 shows resistor values that ensure the maximum drive level for the CLKIN port is not exceeded for all combinations of 5% tolerance on the driver V_{DD} , V_{DDOO} , and 5% resistor tolerances. The resistor values can be adjusted to reduce the loading for a slower and weaker LVCMOS driver by increasing the impedance of the R1–R2 divider. To better assist with this assessment, the total load (Ro+Rs+R1+R2) on the driver is included in the table.

Table 22.	Nominal Voltage	Divider Values	for Overdriving	I CLKIN wi	ith Sinale-ended	Driver
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LVCMOS Diver V _{DD}	Ro + Rs	R1	R2	Vrx (peak)	Ro+Rs+R1+R2
3.3	50.0	130	75	0.97	255
2.5	50.0	100	100	1.00	250
1.8	50.0	62	130	0.97	242